

TRAN-P151



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Pelham and Burr

Serial: 10/772,029

Group Art Unit: 2818

Filed: February 3, 2004

Examiner: Luu Chuong A

For: METHOD FOR GENERATING A DEEP N-WELL PATTERN FOR AN
INTEGRATED CIRCUIT DESIGN

RESPONSE TO RESTRICTION REQUIREMENT

Dear Sir:

In response to the Official Action mailed November 29, 2005 in the above captioned case, Applicants respectfully request the Examiner to consider the following remarks.